8 7 6 NOTES: 1. INTERPRET DRAWING PER ASME Y14.5-1994. 2. DO NOT SCALE FROM DRAWING. 3. MINIMIZE EDGE CHIPPING. 4. REMOVE ALL SHARP EDGES. 5. ALL MACHINING FLUIDS MUST BE FULLY SYNTHETIC, FULLY WATER SOLUBLE AND FREE OF SULFUR, SILICONE, AND CHLORINE. 6. CYLINDRICAL RADIUS TO BE ADDED TO SURFACE 'S1'. 7. PRISM NOT TO BE USED FOR OPTICAL PURPOSES. 8. INSPECTION POLISH ALL FACES INCLUDING SURFACE 'S1'. 9. STRADDLE & WITHIN .004" [0.1 mm] T.I.R. (TOTAL INDICATED RUNOUT) OF FEATURE 'A''. 10. IDENTICAL GROOVES TO LOCATE AND SEPARATE TWO (SPRING STEEL) WIRES. 11. PLEASE USE LASER ABLATION TO CREATE GROOVES. A HIGH SURFACE QUALITY IS REQUIRED ON THE INTERNAL SURFACES OF THE GROOVES AND IN THE GENERAL VICINITY OF THE GROOVES. PLEASE DISCUSS BEST EFFORTS WITH LIGO STAFF.	5 4 REV. DATE V1 02 FEB 200 V2 20 FEB 200 V3 31 MAR 200 V4 23 JUN 201	9 E0900024 - 09 E0900099 -
12. BAG AND TAG PARTS INDIVIDUALLY WITH THEIR DRAWING PART NUMBER, REVISION, AND SERIAL NUMBER. SERIAL NUMBERS START AT 500 FOR THE FIRST ARTICLE AND PROCEED CONSECUTIVELY. EXAMPLE: DXXXXXXX-VY, S/N XXX E	GROOVES, REFER TO NOTE 10 AND NOTE 11.	R.0005 MIN [0.03] [0.03] [0.13] REF .005 [0.13] REF DETAIL A SCALE 70 : 1 DETAIL A SCALE 70 : 1 DETAIL A COULT AND
$B = \begin{bmatrix} 0 \\ 0 \\ 0 \\ 0 \\ 0 \\ 0 \\ 0 \\ 0 \\ 0 \\ 0$	Q R 2.9626" +/- 0.0098" R 75.25mm ±0.25mm SEE NOTE 6.	CHAMFER 0.02 x 45° ±5° ON ALL EDGES ADJACENT TO SURFACE 'S1' C (24 [6.02] BEFORE RADIUS OR CHAMFER (ADUS OR CHAMFER)
A DETAIL B SCALE 8 : 1 A DIMENSIONS ARE IN INCHES [MM] TOLERANCES: XX ± .01 XXX ± .005 ANGULAR ± 1.0° MATERIAL SAPPHIRE FINISH SAPPHIRE AND INSPECTION POLISH	CALIFORNIA INSTITUTE OF TECHNOLOGY MASSACHUSETTS INSTITUTE OF TECHNOLOGY PART NAME SYSTEM DESIGNER C. TORRIE SYSTEM SUB-SYSTEM DESIGNER C. TORRIE ADVANCED LIGO SUS DRAFTER M. MEYER NEXT ASSY HSTS LOWER MASS CHECKER J. ROMIE 5 4 3	

	3	2	1
REV	. DATE	DCN #	DRAWING TREE #
v1	02 FEB 2009	RFI USE ONLY (NO DCN)	-
v2	20 FEB 2009	E0900024	-
v3	31 MAR 2009	E0900099	-
V4	23 JUN 2010	E1000231	_

